

PCTEST ENGINEERING LABORATORY, INC.

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## MEASUREMENT REPORT FCC PART 15.407 (UNII)

#### **Applicant Name:**

Samsung Electronics, Co. Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 443-742, Korea Date of Testing: 7/19/2013 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 0Y1307101235.A3L

FCC ID:	A3LSCHI545	
APPLICANT:	Samsung Electronics, Co. Ltd.	
Application Type:	Class II Permissive Change	
Model(s):	SCH-1545	
EUT Type:	Portable Handset	
FCC Classification:	Unlicensed National Information Infrastructure (UNII)	
FCC Rule Part(s):	Part 15.407	
Test Procedure(s):	KDB 789033 v01r03, KDB 648474 v01r02	
Class II Permissive Change:	Please see FCC change documents.	

03/29/2013

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in KDB 789033 v01r03 and KDB 648474 v01r02. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

andy Ortanez President

**Original Grant Date:** 



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## MEASUREMENT REPORT FCC Part 15.407

#### § 2.1033 General Information

APPLICANT:	Samsung Electronics, Co. Ltd.					
APPLICANT ADDRESS:	129, Samsung-ro, Ma	129, Samsung-ro, Maetan dong,				
	Yeongtong-gu, Suwo	Yeongtong-gu, Suwon-si, Gyeonggi-do 443-742, Korea				
TEST SITE:	PCTEST ENGINEER	ING LABORATO	RY, INC.			
TEST SITE ADDRESS:	7185 Oakland Mills R	oad, Columbia, M	1D 21046 USA			
FCC RULE PART(S):	Part 15.407					
IC SPECIFICATION(S):	RSS-210 Issue 8					
MODEL NAME:	SCH-1545					
FCC ID:	A3LSCHI545					
Test Device Serial No.:	FK-195-B	Production	Pre-Production			
FCC CLASSIFICATION:	Unlicensed National Information Infrastructure (UNII)					
DATE(S) OF TEST:	7/19/2013	7/19/2013				
TEST REPORT S/N:	0Y1307101235.A3L					

## **Test Facility / Accreditations**

#### Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.



Cartificate of Accordit.

on to ISOIFC 17025-200

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- PCTEST facility is an FCC registered (PCTEST Reg. No. 159966) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (2451B-1).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451B-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

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#### INTRODUCTION 1.0

#### 1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

#### 1.2 PCTEST Test Location

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Internt'I (BWI) airport, the city of Baltimore and the Washington, DC area. (See Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The site coordinates are 39° 10'23" N latitude and 76° 49'50" W longitude. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2009 on February 15, 2012.

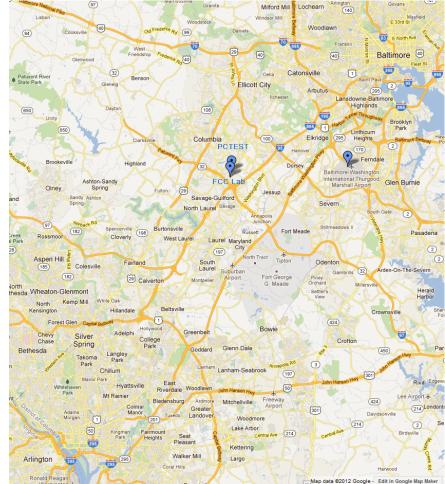


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

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## 2.0 PRODUCT INFORMATION

### 2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSCHI545**. The test data contained in this report pertains only to the emissions due to the EUT's UNII transmitter.

#### 2.2 Device Capabilities

This device contains the following capabilities:

850/1900 CDMA/EvDO Rev0/A (BC0, BC1), 850/1900 GSM/GPRS/EDGE, 850/1900 WCDMA/HSPA, Band 4(5,10,15,20 MHz BW), 13 (5,10 MHz BW) LTE, 802.11a/ac/b/g/n WLAN (DTS/NII), Bluetooth (1x,EDR, LE), NFC

#### 2.3 Test Configuration

The Samsung Portable Handset FCC ID: A3LSCHI545 was tested per the guidance of KDB 789033 v01r03. ANSI C63.10-2009 was used to reference the appropriate EUT setup for radiated spurious emissions testing and AC line conducted testing. See Section and 6.1 of this test report for a description of the radiated emissions test setup.

This device supports a wireless charging cover. Additional emissions testing was performed per KDB 648474 D03 v01r02. The handset was placed on the representative charging pad (FCC ID: A3LEPP100IJWU) under normal conditions and in a simulated call configuration. The additional worst case emissions are reported herein and identified as WCC.

#### 2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and/or no modifications were made during testing.

#### 2.5 Labeling Requirements

Per 2.1074 & 15.19; Docket 95-19

The label shall be permanently affixed at a conspicuous location on the device; instruction manual or pamphlet supplied to the user and be readily visible to the purchaser at the time of purchase. However, when the device is so small wherein placement of the label with specified statement is not practical, only the trade name and FCC ID must be displayed on the device per Section 15.19(a)(5). Please see attachment for FCC ID label and label location.

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## 3.0 DESCRIPTION OF TEST

### 3.1 Evaluation Procedure

The measurement procedures described in the American National Standard for Testing Unlicensed Wireless Devices (ANSI C63.10-2009) and the guidance provided in KDB 789033 v01r03 were used in the measurement of **Samsung Portable Handset FCC ID: A3LSCHI545**.

Deviation from measurement procedure.....None

## 3.2 Radiated Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. An ETS Lindgren Model 2188 raised turntable is used for radiated measurement. It is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. A 78cm high PVC support structure is placed on top of the turntable. A <sup>3</sup>/<sub>4</sub>" (~1.9cm) sheet of high density polyethylene is used as the table top and is placed on top of the PVC supports to bring the total height of the table to 80cm.

For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up was placed on top of the 0.8 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found.

Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, whichever produced the worst-case emissions. For the EUT positioning, "H" is defined with the EUT lying flat on the test surface, "H2" is defined with the EUT standing up on its side, and "V" is defined with the EUT standing upright.

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## 4.0 ANTENNA REQUIREMENTS

#### Excerpt from §15.203 of the FCC Rules/Regulations:

"An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section."

- The antennas of the Portable Handset are permanently attached.
- There are no provisions for connection to an external antenna.

#### **Conclusion:**

The Samsung Portable Handset FCC ID: A3LSCHI545 unit complies with the requirement of §15.203.

	Band 1			Band 2		Band 3
Ch.	Frequency (MHz)		Ch.	Frequency (MHz)	Ch.	Frequency (MHz)
36	5180		52	5260	100	5500
:	:		:	:	:	:
42	5210		56	5280	116	5580
:	:		:	:	:	:
48	5240		64	5320	140	5700
.0		1 - 1				

Table 4-1. 802.11a / 802.11n (20MHz) Frequency / Channel Operations

	Band 1	_		Band 2
Ch.	Frequency (MHz)		Ch.	Frequency (MHz)
38	5190		54	5270
:	:		:	:
46	5230		62	5310

	Band 3
Ch.	Frequency (MHz)
102	5510
•••	:
110	5550
:	:
134	5670
-	

Table 4-2. 802.11n (40MHz BW) Frequency / Channel Operations

	Band 1		Band 2		Band 3
Ch.	Frequency (MHz)	Ch.	Frequency (MHz)	Ch.	Frequency (MHz)
42	5210	58	5290	106	5530

Table 4-3. 802.11ac (80MHz BW) Frequency / Channel Operations

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## 5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	3/29/2013	Annual	3/29/2014	N/A
-	RE2	Radiated Emissions Cable Set (VHF/UHF)	3/29/2013	Annual	3/29/2014	N/A
Agilent	8447D	Broadband Amplifier	5/31/2013	Annual	5/31/2014	2443A01900
Com-Power	AL-130	9kHz - 30MHz Loop Antenna	6/26/2013	Annual	6/26/2014	121034
Emco	3115	Horn Antenna (1-18GHz)	1/12/2012	Biennial	1/12/2014	9704-5182
ETS Lindgren	3160-09	18-26.5 GHz Standard Gain Horn	5/30/2012	Biennial	5/30/2014	135427
ETS Lindgren	3160-10	26.5-40 GHz Standard Gain Horn	6/6/2012	Biennial	6/6/2014	130993
Huber+Suhner	Sucoflex 102A	40GHz Radiated Cable	3/1/2013	Annual	3/1/2014	251425001
K & L	6000/T18000	High Pass Filter	3/4/2013	Annual	3/4/2014	1
Rohde & Schwarz	TS-PR18	1-18 GHz Pre-Amplifier	5/31/2013	Annual	5/31/2014	100071
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	5/31/2013	Annual	5/31/2014	100040
Rohde & Schwarz	TS-PR40	26.5-40 GHz Pre-Amplifier	6/6/2012	Biennial	6/6/2014	100037
Rohde & Schwarz	ESU26	EMI Test Receiver	2/25/2013	Annual	2/25/2014	100342
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	1/26/2012	Biennial	1/26/2014	A051107

Table 5-1. Annual Test Equipment Calibration Schedule

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## 6.0 TEST RESULTS

## 6.1 Summary

Company Name:	Samsung Electronics, Co. Ltd.
FCC ID:	A3LSCHI545
Method/System:	Unlicensed National Information Infrastructure (UNII)
Data Rate(s) Tested:	<u>6, 9, 12, 18, 24, 36, 48, 54Mbps (802.11a)</u>
	<u>6.5/7.2, 13/14.4, 19.5/21.7, 26/28.9, 39/43.3, 52/57.8, 58.5/65, 65/72.2 (n – 20MHz)</u>
	<u>13.5/15, 27/30, 40.5/45, 54/60, 81/90, 108/120, 121.5/135, 135/150 (n – 40MHz BW)</u>
	<u>29.3/32.5Mbps, 58.5/65Mbps, 87.8/97.5Mbps, 117/130Mbps, 175.5/195Mbps,</u>
	<u>234/260Mbps, 263.3/292.5Mbps, 292.5/325Mbps, 351/390Mbps, 390/433.3Mbps</u>
	<u>(ac – 80MHz BW)</u>

FCC Part Section(s)	RSS Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
TRANSMITTE	R MODE (TX)					
15.407(b)(1), (2),(3)	RSS-210 [A9.2]	Undesirable Emissions	< -27 dBm/MHz EIRP (5150-5350MHz, 5470-5725MHz)		PASS	Sections 6.2, 6.3
15.205, 15.407(b)(1), (5), (6)	RSS-Gen [7.2.3.2]	General Field Strength Limits (Restricted Bands and Radiated Emission Limits)	Emissions in restricted bands must meet the radiated limits detailed in 15.209 (RSS-210 table 3 limits)	RADIATED	PASS	Sections 6.4, 6.5, 6.6, 6.7

Table 6-1. Summary of Test Results

### Notes:

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All channels, modes, and modulations/data rates were investigated among all UNII bands. The test results shown in the following sections represent the worst case emissions.

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#### 6.2 Radiated Spurious Emission Measurements §15.407(b)(1), (6), §15.205, §15.209; RSS-210 [A9.2]

#### Test Overview and Limit

All out of band radiated spurious emissions are measured with a spectrum analyzer connected to a receive antenna while the EUT is operating at its maximum duty cycle (>98%), at its maximum power control level, as defined in KDB 789033 v01r03, and at the appropriate frequencies. All channels, modes (e.g. 802.11a, 802.11n (20MHz BW) and 802.11n (40MHz BW)), and modulations/data rates were investigated among all UNII bands. Only the radiated emissions of the configuration that produced the worst case emissions are reported in this section.

## All out of band emissions appearing in a restricted band as specified in Section 15.205 of the Title 47 CFR must not exceed the limits shown in Table 6-2 per Section 15.209.

Frequency	Field Strength [µV/m]	Measured Distance [Meters]
0.009 – 0.490 MHz	2400/F (kHz)	300
0.490 – 1.705 MHz	24000/F (kHz)	30
1.705 – 30.00 MHz	30	30
30.00 – 88.00 MHz	100	3
88.00 – 216.0 MHz	150	3
216.0 – 960.0 MHz	200	3
Above 960.0 MHz	500	3

Table 6-2. Radiated Limits

#### **Test Procedures Used**

KDB 789033 v01r03 – Section H

#### Test Settings

#### Average Measurements above 1GHz (Method AD)

- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2. RBW = 1MHz
- 3. VBW = 3MHz
- 4. Detector = power average (RMS)
- 5. Number of measurement points = 1001 (Number of points must be  $\geq 2 \times \text{span/RBW}$ )
- 6. Averaging type = power (RMS)
- 7. Sweep time = auto couple
- 8. Trace was averaged over 100 sweeps

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#### Peak Measurements above 1GHz

- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2. RBW = 1MHz
- 3. VBW = 3MHz
- 4. Detector = peak
- 5. Sweep time = auto couple
- 6. Trace mode = max hold
- 7. Trace was allowed to stabilize

#### Peak Measurements below 1GHz

- 1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
- 2. Span was set greater than 1MHz
- 3. RBW = 120kHz
- 4. Detector = CISPR quasi-peak
- 5. Sweep time = auto couple
- 6. Trace was allowed to stabilize

#### Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

3 Meter EMC Chamber

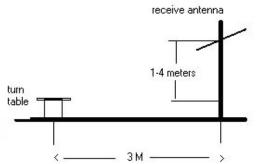


Figure 6-1. Test Instrument & Measurement Setup

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#### Test Notes

- All radiated spurious emissions levels were measured in a radiated test setup per the guidance of KDB 789033 v01r03 Section H.
- 2. All spurious emissions lying in restricted bands specified in §15.205 are below the limit shown in Table 6-2. All spurious emissions that do not lie in a restricted band are subject to a peak limit of -27dBm/MHz. At a distance of 3 meters, the field strength limit in dBµV/m can be determined by adding a "conversion" factor of 95.2dB to the EIRP limit of -27dBm/MHz to obtain the limit for out of band spurious emissions of 68.2dBµV/m.
- 3. The antenna is manipulated through typical positions, polarity and length during the tests. The EUT is manipulated through three orthogonal planes.
- 4. This unit was tested with its standard battery.
- 5. The spectrum is measured from 9kHz to the 10th harmonic of the fundamental frequency of the transmitter using CISPR quasi peak detector below 1GHz. Above 1 GHz, average and peak measurements were taken using linearly polarized horn antennas. The worst-case emissions are reported however emissions whose levels were not within 20dB of the respective limits were not reported.
- 6. Emissions below 18GHz were measured at a 3 meter test distance while emissions above 18GHz were measured at a 1 meter test distance with the application of a distance correction factor.
- 7. Average levels at -135dBm and peak levels at -125dBm represent the analyzer noise floor and signify that no emission was detected.

#### Sample Calculations

#### **Determining Spurious Emissions Levels**

- ο Field Strength Level [dBμV/m] = Analyzer Level [dBm] + 107 + AFCL [dB/m]
- AFCL [dB/m] = Antenna Factor [dB/m] + Cable Loss [dB]
- Margin [dB] = Field Strength Level  $[dB\mu V/m]$  Limit  $[dB\mu V/m]$

#### Radiated Band Edge Measurement Offset

• The amplitude offset shown in the radiated restricted band edge plots was calculated using the formula:

Offset (dB) = (Antenna Factor + Cable Loss + 10 dB Attenuator) – Preamplifier Gain

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Worst Case Mode:	802.11a
Worst Case Transfer Rate:	6 Mbps
Distance of Measurements:	1 & 3 Meters
Operating Frequency:	5180MHz
Channel:	36

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dB <sub>µ</sub> V/m]	Margin [dB]
	10360.00	-103.37	Peak	Н	48.17	51.80	68.20	-16.40
*	15540.00	-135.00	Average	Н	54.56	26.56	53.98	-27.42
*	15540.00	-125.00	Peak	Н	54.56	36.56	73.98	-37.42
*	20720.00	-135.00	Average	Н	44.04	16.04	53.98	-37.94
*	20720.00	-125.00	Peak	Н	44.04	26.04	73.98	-47.94
	25900.00	-125.00	Peak	Н	44.84	26.84	68.20	-41.36

#### **Table 6-3. Radiated Measurements**

Worst Case Mode: Worst Case Transfer Rate: Distance of Measurements: Operating Frequency: Channel:

802.11a
6 Mbps
1 & 3 Meters
5200MHz
40

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
	10400.00	-104.38	Peak	Н	48.09	50.71	68.20	-17.49
*	15600.00	-135.00	Average	Н	54.42	26.42	53.98	-27.56
*	15600.00	-125.00	Peak	Н	54.42	36.42	73.98	-37.56
*	20800.00	-135.00	Average	Н	44.03	16.03	53.98	-37.95
*	20800.00	-125.00	Peak	Н	44.03	26.03	73.98	-47.95
	26000.00	-125.00	Peak	Н	44.96	26.96	68.20	-41.24

#### **Table 6-4. Radiated Measurements**

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dogo 12 of 11
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802.11a
6 Mbps
1 & 3 Meters
5240MHz
48

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
	10480.00	-103.87	Peak	Н	48.03	51.16	68.20	-17.04
*	15720.00	-135.00	Average	Н	54.45	26.45	53.98	-27.53
*	15720.00	-125.00	Peak	Н	54.45	36.45	73.98	-37.53
*	20960.00	-135.00	Average	Н	44.00	16.00	53.98	-37.98
*	20960.00	-125.00	Peak	Н	44.00	26.00	73.98	-47.98
	26200.00	-125.00	Peak	Н	44.75	26.75	68.20	-41.45

**Table 6-5. Radiated Measurements** 

Worst Case Mode: Worst Case Transfer Rate: Distance of Measurements: Operating Frequency: Channel:

802.11a
6 Mbps
1 & 3 Meters
5260MHz
52

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
10520.00	-103.67	Peak	Η	48.18	51.50	68.20	-16.70
15780.00	-135.00	Average	Н	54.53	26.53	53.98	-27.45
15780.00	-125.00	Peak	Н	54.53	36.53	73.98	-37.45
21040.00	-135.00	Average	Н	43.95	15.95	53.98	-38.03
21040.00	-125.00	Peak	Н	43.95	25.95	73.98	-48.03
26300.00	-125.00	Peak	Н	44.78	26.78	68.20	-41.42
	[MHz] 10520.00 15780.00 15780.00 21040.00 21040.00	Frequency [MHz]         Level [dBm]           10520.00         -103.67           15780.00         -135.00           15780.00         -125.00           21040.00         -135.00           21040.00         -125.00	Frequency [MHz]Level [dBm]Detector10520.00-103.67Peak15780.00-135.00Average15780.00-125.00Peak21040.00-135.00Average21040.00-125.00Peak26300.00-125.00Peak	Frequency [MHz]         Level [dBm]         Detector         Pol. [H/V]           10520.00         -103.67         Peak         H           15780.00         -135.00         Average         H           15780.00         -125.00         Peak         H           21040.00         -135.00         Average         H           21040.00         -125.00         Peak         H           26300.00         -125.00         Peak         H	Frequency [MHz]Level [dBm]DetectorPol. [H/V]AFCL [dBm]10520.00-103.67PeakH48.1815780.00-135.00AverageH54.5315780.00-125.00PeakH54.5321040.00-135.00AverageH43.9521040.00-125.00PeakH43.9526300.00-125.00PeakH44.78	Frequency [MHz]         Level [dBm]         Detector         Pol. [H/V]         AFCL [dB/m]         Strength [dBμV/m]           10520.00         -103.67         Peak         H         48.18         51.50           15780.00         -135.00         Average         H         54.53         26.53           15780.00         -125.00         Peak         H         54.53         36.53           21040.00         -135.00         Average         H         43.95         15.95           21040.00         -125.00         Peak         H         43.95         25.95	Frequency [MHz]Level [dBm]DetectorPol. [H/V]AFCL [dB/m]Strength [dB/m]Limit [dBµV/m]10520.00-103.67PeakH48.1851.5068.2015780.00-135.00AverageH54.5326.5353.9815780.00-125.00PeakH54.5336.5373.9821040.00-135.00AverageH43.9515.9553.9821040.00-125.00PeakH43.9525.9573.9826300.00-125.00PeakH44.7826.7868.20

Table 6-6. Radiated Measurements

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dage 14 of 11
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Worst Case Mode:	802.11a
Worst Case Transfer Rate:	6 Mbps
Distance of Measurements:	1 & 3 Meters
Operating Frequency:	5280MHz
Channel:	56

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dB <sub>µ</sub> V/m]	Margin [dB]
	10560.00	-104.06	Peak	Н	48.49	51.43	68.20	-16.77
*	15840.00	-135.00	Average	Н	54.66	26.66	53.98	-27.32
*	15840.00	-125.00	Peak	Н	54.66	36.66	73.98	-37.32
*	21120.00	-135.00	Average	Н	43.83	15.83	53.98	-38.15
*	21120.00	-125.00	Peak	Н	43.83	25.83	73.98	-48.15
	26400.00	-125.00	Peak	Н	44.72	26.72	68.20	-41.48

#### Table 6-7. Radiated Measurements

Worst Case Mode: Worst Case Transfer Rate: Distance of Measurements: Operating Frequency: Channel:

802.11a
6 Mbps
1 & 3 Meters
5320MHz
64

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
*	10640.00	-116.31	Average	Н	49.07	39.75	53.98	-14.23
*	10640.00	-102.98	Peak	Н	49.07	53.08	73.98	-20.90
*	15960.00	-135.00	Average	Н	54.99	26.99	53.98	-26.99
*	15960.00	-125.00	Peak	Н	54.99	36.99	73.98	-36.99
*	21280.00	-135.00	Average	Н	43.71	15.71	53.98	-38.27
*	21280.00	-125.00	Peak	Н	43.71	25.71	73.98	-48.27
	26600.00	-125.00	Peak	Н	44.53	26.53	68.20	-41.67
			Table 0.0	Dellate	d Meesur			

#### Table 6-8. Radiated Measurements

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dage 15 of 11
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Worst Case Mode:	802.11a		
Worst Case Transfer Rate:	6 Mbps		
Distance of Measurements:	1 & 3 Meters		
Operating Frequency:	5500MHz		
Channel:	100		

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
*	11000.00	-115.12	Average	Н	49.89	41.77	53.98	-12.21
*	11000.00	-104.02	Peak	Н	49.89	52.87	73.98	-21.11
	16500.00	-125.00	Peak	Н	56.14	38.14	68.20	-30.06
	22000.00	-125.00	Peak	Н	43.95	25.95	68.20	-42.25
	27500.00	-125.00	Peak	Н	48.50	30.50	68.20	-37.70

### Table 6-9. Radiated Measurements

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Worst Case Mode: Worst Case Transfer Rate: Distance of Measurements: Operating Frequency: Channel:

802.11a	
6 Mbps	
1 & 3 Meters	
5580MHz	
116	

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
*	11160.00	-115.33	Average	Н	50.05	41.72	53.98	-12.26
*	11160.00	-102.82	Peak	Н	50.05	54.23	73.98	-19.75
	16740.00	-125.00	Peak	Н	56.20	38.20	68.20	-30.00
*	22320.00	-135.00	Average	Н	44.47	16.47	53.98	-37.50
*	22320.00	-125.00	Peak	Н	44.47	26.47	73.98	-47.50
	27900.00	-125.00	Peak	Н	48.02	30.02	68.20	-38.18

Table 6-10. Radiated Measurements

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager			
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05/07/2013



Worst Case Mode:	802.11a		
Worst Case Transfer Rate:	6 Mbps		
Distance of Measurements:	1 & 3 Meters		
Operating Frequency:	5700MHz		
Channel:	140		

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
*	11400.00	-115.78	Average	Н	49.82	41.04	53.98	-12.94
*	11400.00	-103.96	Peak	Н	49.82	52.86	73.98	-21.12
	17100.00	-125.00	Peak	Н	57.45	39.45	68.20	-28.75
*	22800.00	-135.00	Average	Н	44.47	16.47	53.98	-37.51
*	22800.00	-125.00	Peak	Н	44.47	26.47	73.98	-47.51
	28500.00	-125.00	Peak	Н	48.08	30.08	68.20	-38.12

Table 6-11. Radiated Measurements

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager		
Test Report S/N:	Test Dates:	EUT Type:		Dogo 17 of 41		
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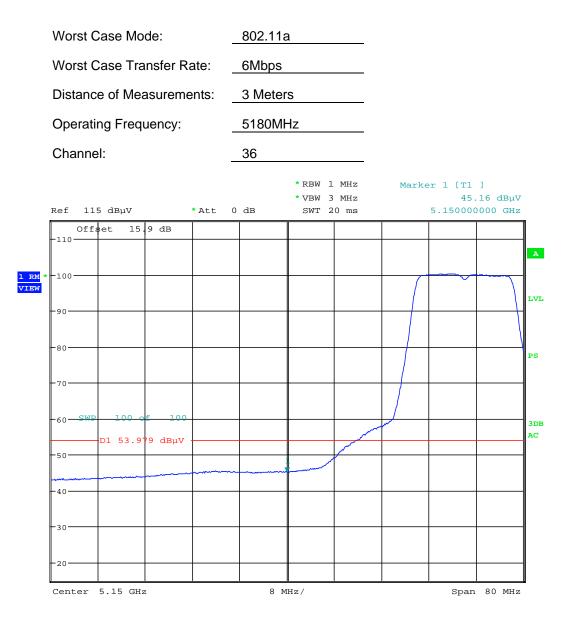
Worst Case Mode:	802.11a		
Worst Case Transfer Rate:	6 Mbps		
Distance of Measurements:	1 & 3 Meters		
Operating Frequency:	5180MHz		
Channel:	36		

	Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol. [H/V]	AFCL [dB/m]	Field Strength [dB <sub>µ</sub> V/m]	Limit [dBµV/m]	Margin [dB]
	10360.00	-103.93	Peak	Н	48.17	51.24	68.20	-16.96
*	15540.00	-166.58	Average	Н	54.56	26.56	53.98	-27.42
*	15540.00	-125.00	Peak	Н	54.56	36.56	73.98	-37.42
*	20720.00	-171.32	Average	Н	44.04	16.04	53.98	-37.94
*	20720.00	-125.00	Peak	Н	44.04	26.04	73.98	-47.94
	25900.00	-125.00	Peak	Н	44.84	26.84	68.20	-41.36

 Table 6-12. Radiated Measurements with Wireless Charging Cover

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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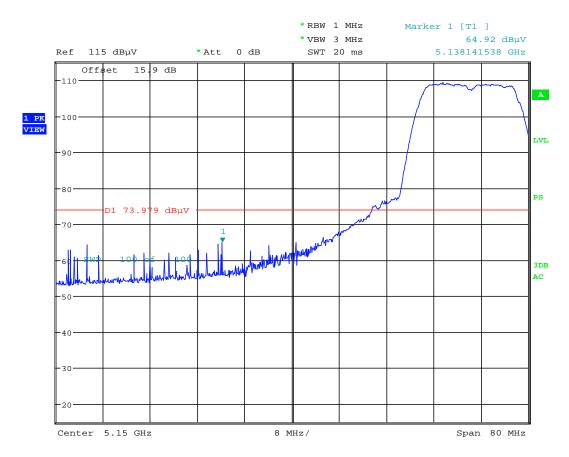


Date: 19.JUL.2013 09:26:54

#### Plot 6-1. Radiated Restricted Lower Band Edge Plot (Average – UNII Band 1)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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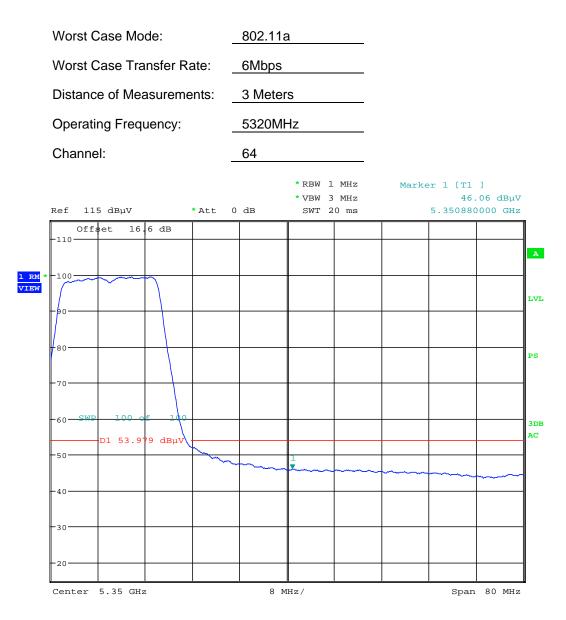


Date: 19.JUL.2013 09:28:01

#### Plot 6-2. Radiated Restricted Lower Band Edge Plot (Peak - UNII Band 1)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Page 20 of 41
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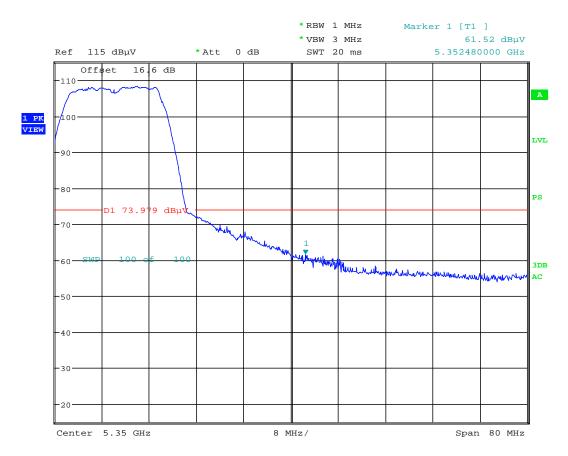


Date: 19.JUL.2013 09:42:27

#### Plot 6-3. Radiated Restricted Upper Band Edge Plot (Average – UNII Band 2)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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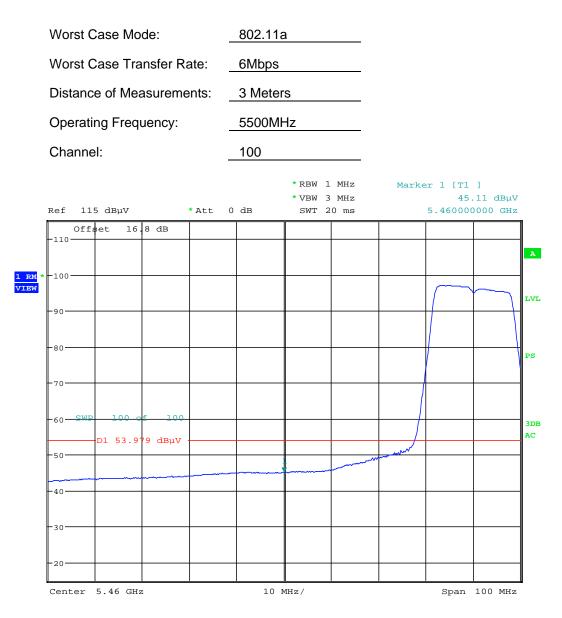


Date: 19.JUL.2013 09:44:35

#### Plot 6-4. Radiated Restricted Upper Band Edge Plot (Peak – UNII Band 2)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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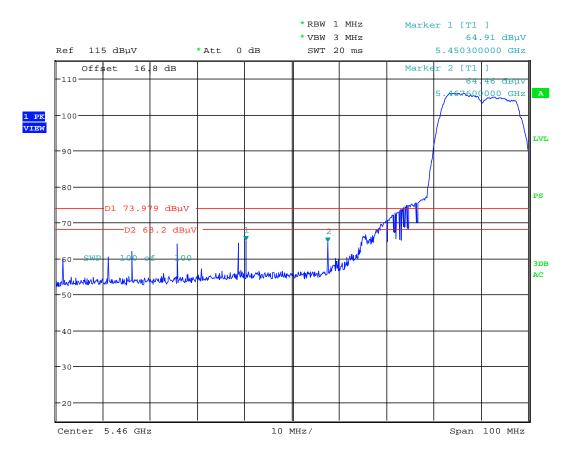


Date: 19.JUL.2013 10:06:28

#### Plot 6-5. Radiated Restricted Lower Band Edge Plot (Average – UNII Band 3)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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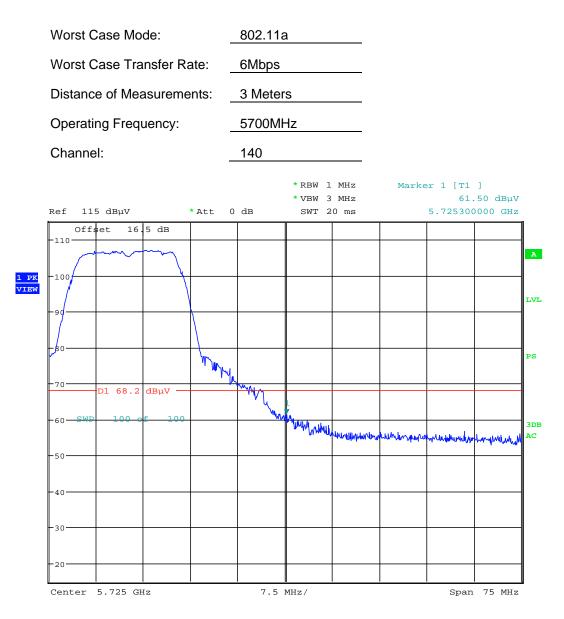


Date: 19.JUL.2013 10:08:03

#### Plot 6-6. Radiated Restricted Lower Band Edge Plot (Peak - UNII Band 3)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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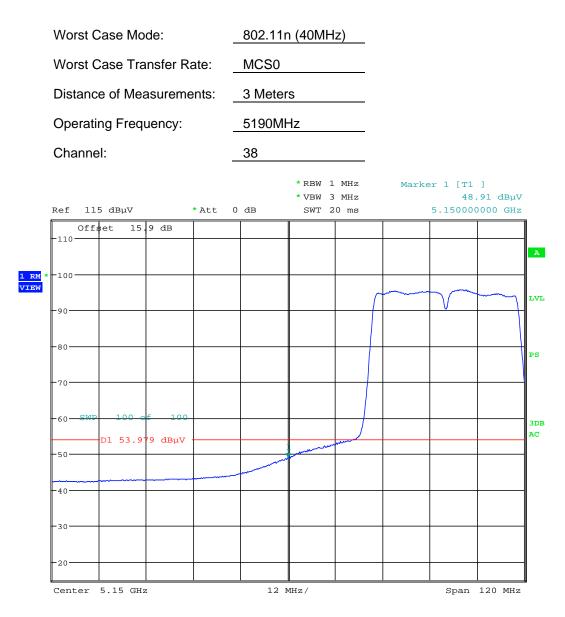


Date: 19.JUL.2013 10:28:34



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0 2013 PCTEST Engineering Laboratory, Inc.				V 2.3



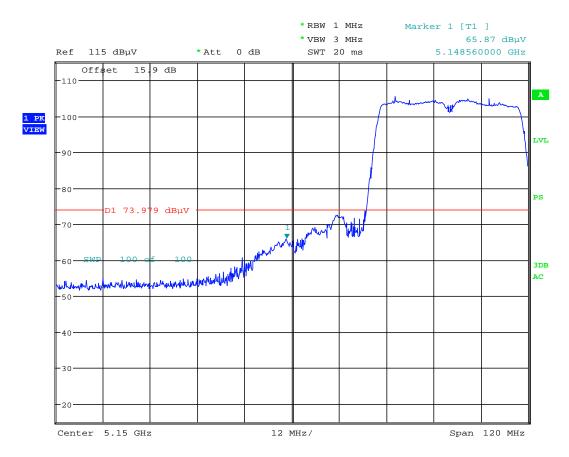


Date: 19.JUL.2013 09:30:30

#### Plot 6-8. Radiated Restricted Lower Band Edge Plot (Average - UNII Band 1)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dage 26 of 44
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2013 PCTEST Engineering Laboratory, Inc.				V 2.3



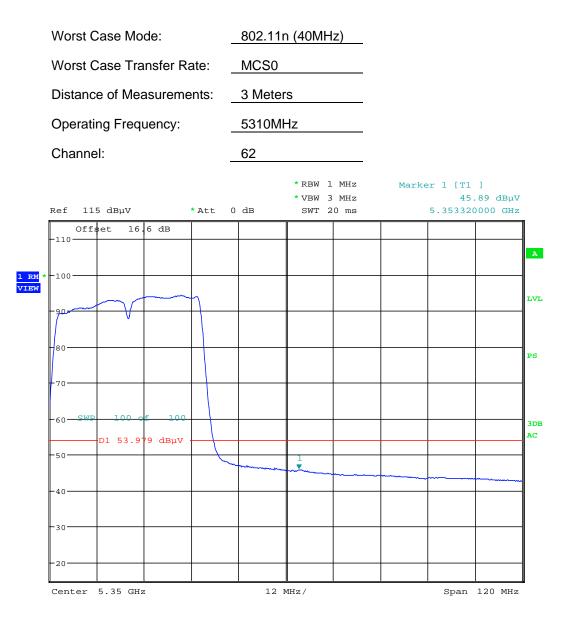


Date: 19.JUL.2013 09:31:20

#### Plot 6-9. Radiated Restricted Lower Band Edge Plot (Peak - UNII Band 1)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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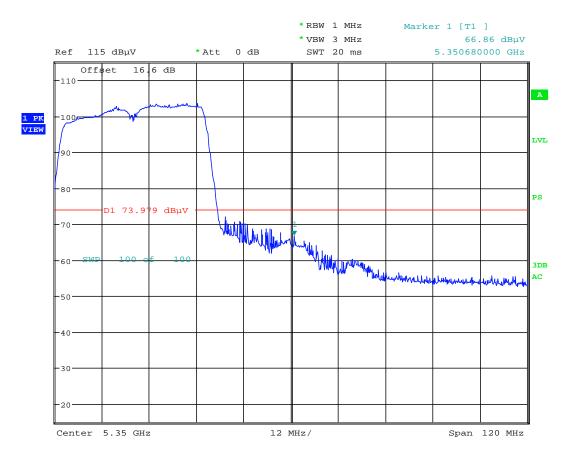


Date: 19.JUL.2013 09:47:43

#### Plot 6-10. Radiated Restricted Upper Band Edge Plot (Average – UNII Band 2)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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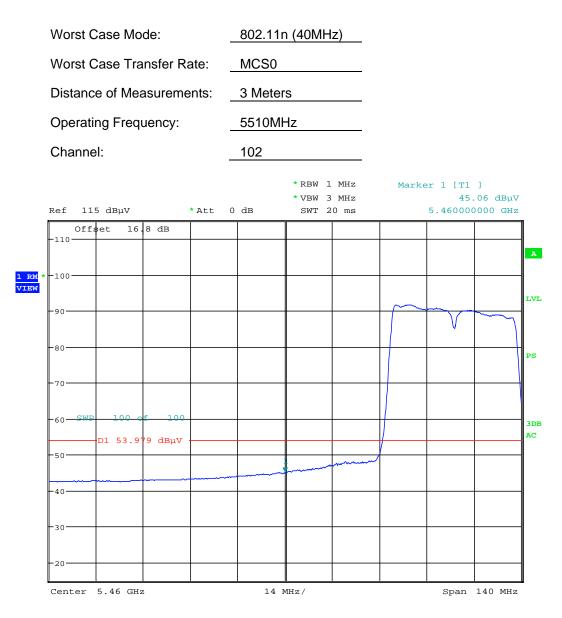


Date: 19.JUL.2013 09:46:45

#### Plot 6-11. Radiated Restricted Upper Band Edge Plot (Peak – UNII Band 2)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Page 29 of 41
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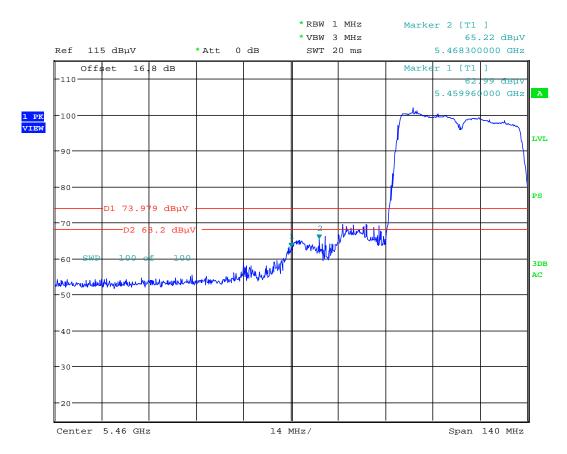


Date: 19.JUL.2013 10:11:46

#### Plot 6-12. Radiated Restricted Lower Band Edge Plot (Average – UNII Band 3)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Page 30 of 41
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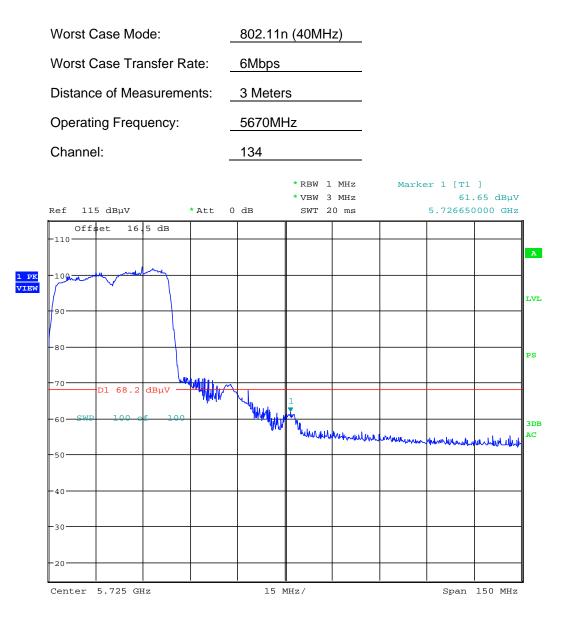


Date: 19.JUL.2013 10:10:07

#### Plot 6-13. Radiated Restricted Lower Band Edge Plot (Peak – UNII Band 3)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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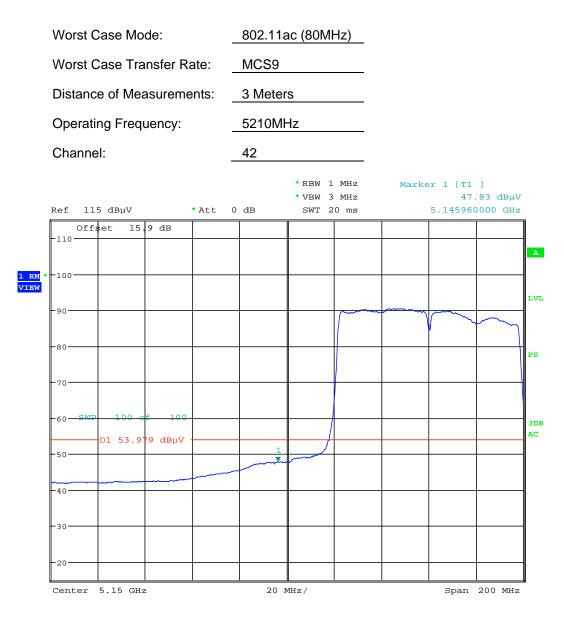


Date: 19.JUL.2013 10:32:00

#### Plot 6-14. Radiated Restricted Lower Band Edge Plot (Average – UNII Band 3)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Daga 22 of 44
0Y1307101235.A3L	7/19/2013	Portable Handset		Page 32 of 41
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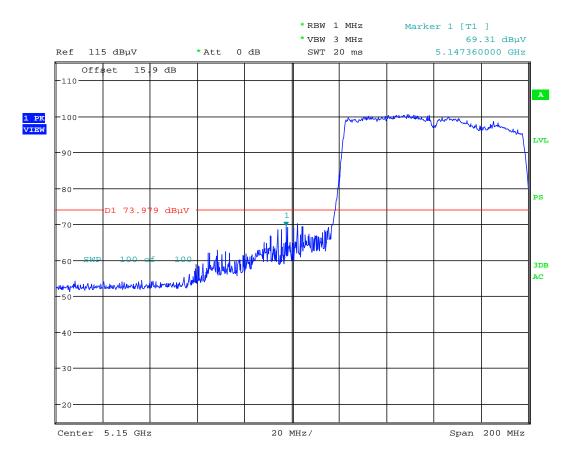


Date: 19.JUL.2013 09:34:47

#### Plot 6-15. Radiated Restricted Lower Band Edge Plot (Average - UNII Band 1)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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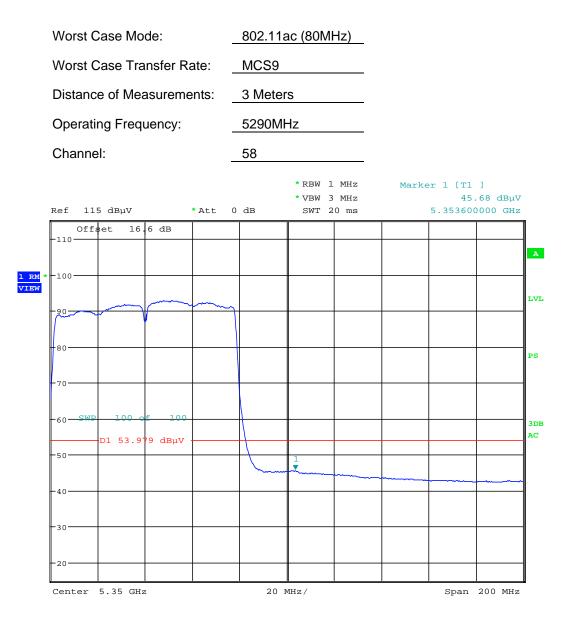


Date: 19.JUL.2013 09:33:34

#### Plot 6-16. Radiated Restricted Lower Band Edge Plot (Peak – UNII Band 1)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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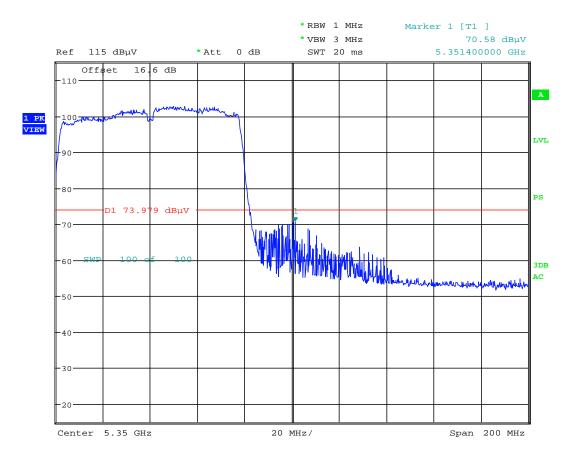


Date: 19.JUL.2013 09:51:36

#### Plot 6-17. Radiated Restricted Upper Band Edge Plot (Average – UNII Band 2)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager	
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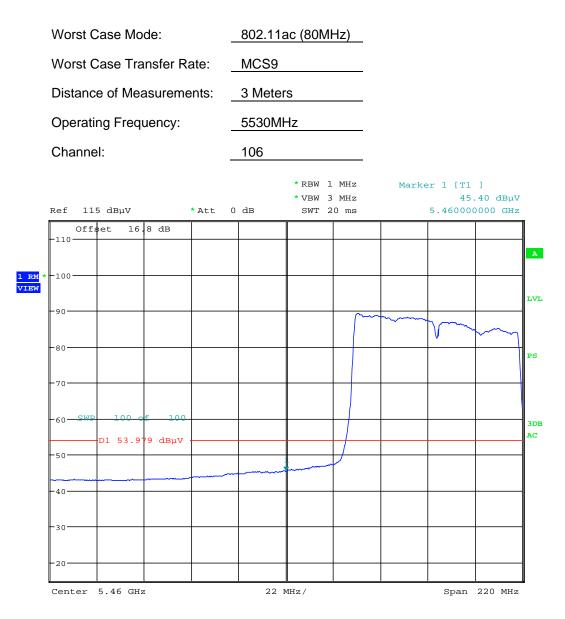


Date: 19.JUL.2013 09:52:51

#### Plot 6-18. Radiated Restricted Upper Band Edge Plot (Peak – UNII Band 2)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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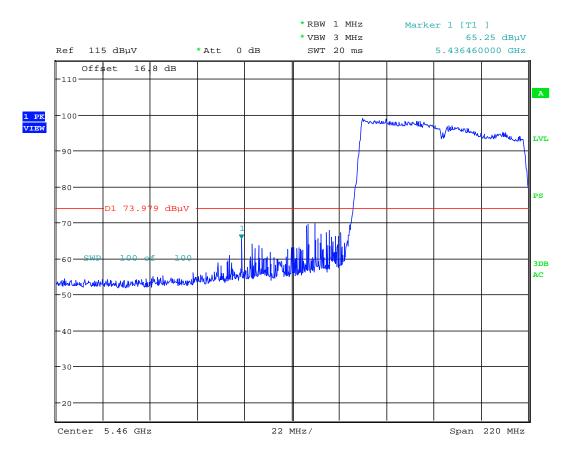


Date: 19.JUL.2013 10:16:31

#### Plot 6-19. Radiated Restricted Lower Band Edge Plot (Average – UNII Band 3)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager	
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Date: 19.JUL.2013 10:18:42

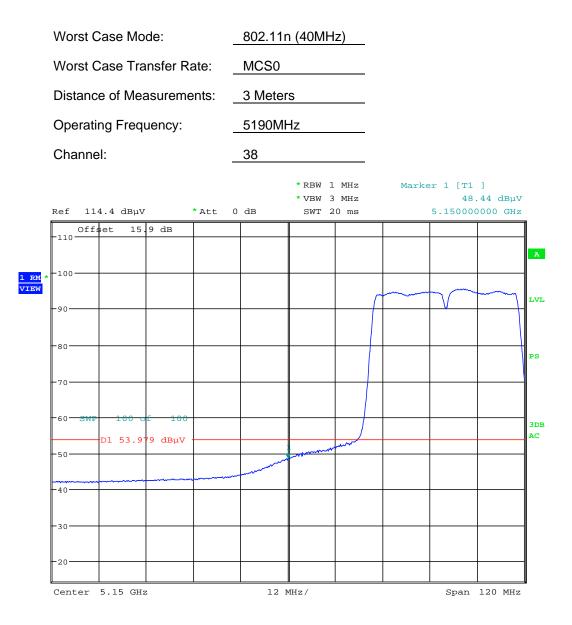
#### Plot 6-20. Radiated Restricted Lower Band Edge Plot (Peak – UNII Band 3)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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# 6.7 Radiated Band Edge Measurements with WCC §15.407(b)(1) and (2), §15.205 & §15.209; RSS-210 [A9.2]

It was determined that the radiated spurious emissions measured while operating on Channel 38 in 40MHz BW produced the highest levels. Thus, this one channel was investigated with a wireless charging cover to determine the effects of the WCC of the radiated emissions.

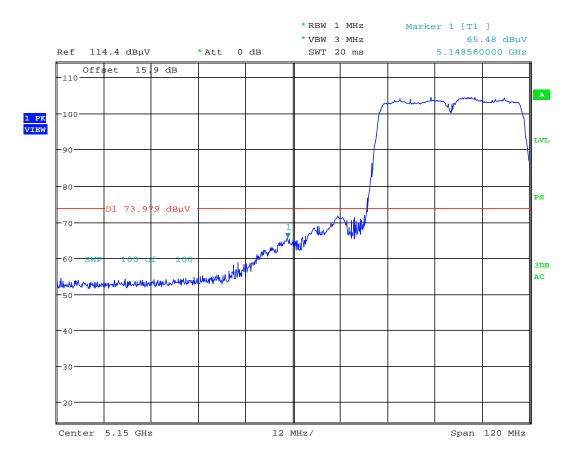


Date: 19.JUL.2013 10:40:10



FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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Date: 19.JUL.2013 10:41:22

#### Plot 6-22. Radiated Restricted Lower Band Edge Plot (Peak – UNII Band 1)

FCC ID: A3LSCHI545		FCC Pt. 15.407 802.11a/n/ac UNII MEASUREMENT REPORT (CLASS II PERMISSIVE CHANGE)	SAMSUNG	Reviewed by: Quality Manager
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## 7.0 CONCLUSION

The data collected relate only the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LSCHI545** is in compliance with Part 15E of the FCC Rules.

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